

N-CHANNEL ENHANCEMENT MODE FIELD MOSFET
Product Summary

V_{SSS}	$R_{SS(ON)} \text{ Max}$	I_S $T_A = +25^\circ\text{C}$
24V	45m Ω @ $V_{GS} = 4.5\text{V}$	1.6A

Features and Benefits

- Built-in G-S Protection Diode against ESD 2kV HBM
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- Halogen and Antimony Free. "Green" Device (Note 3)**

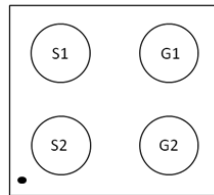
Description and Applications

This new generation MOSFET is designed to minimize the on-state resistance ($R_{SS(ON)}$) and making it ideal for high efficiency power management.

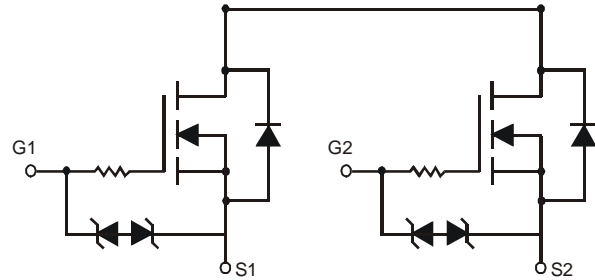
- Battery Management
- Load Switch
- Battery Protection

Mechanical Data

- Case: X2-WLB1616-4
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminal Material: SnAgCu Ball
- Weight: 0.0023 grams (Approximate)



Top View



N-Channel

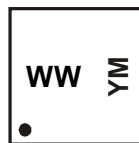
N-Channel

Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMN2036UCB4-7	X2-WLB1616-4	3000/Tape & Reel

- Notes:
- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
 - See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen and Antimony free, "Green" and Lead-Free.
 - Halogen and Antimony free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
 - For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.

Marking Information


VW/WW = Product Type Marking Code
 YM = Date Code Marking
 Y = Year (ex: E = 2017)
 M = Month (ex: 9 = September)

Date Code Key

Year	2015	2016	2017	2018	2019	2020	2021
Code	C	D	E	F	G	H	I

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

Maximum Ratings

Characteristic			Symbol	Value	Unit
Source-Source Voltage			V_{SSS}	24	V
Gate-Source Voltage			V_{GSS}	± 12	V
Continuous Source Current @ $T_A = +25^\circ\text{C}$ (Note 5)	Steady State	$T_A = +25^\circ\text{C}$	I_S	1.6	A
		$T_A = +70^\circ\text{C}$		1.3	
Pulsed Source Current @ $T_A = +25^\circ\text{C}$ (Notes 5 & 6)			I_{SM}	30	A

Thermal Characteristics

Characteristic			Symbol	Value	Unit
Power Dissipation, @ $T_A = +25^\circ\text{C}$ (Note 5)			P_D	1.45	W
Thermal Resistance, Junction to Ambient @ $T_A = +25^\circ\text{C}$ (Note 5)			$R_{\theta JA}$	86.68	$^\circ\text{C/W}$
Operating and Storage Temperature Range			T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Source to Source Breakdown Voltage $T_J = +25^\circ\text{C}$	$V_{(BR)SS}$	24	—	—	V	$I_S = 1\text{mA}, V_{GS} = 0\text{V}$
Zero Gate Voltage Source Current $T_J = +25^\circ\text{C}$	I_{SSS}	—	—	1.0	μA	$V_{SS} = 20\text{V}, V_{GS} = 0\text{V}$
Gate-Body Leakage	I_{GSS}	—	—	± 10	μA	$V_{GS} = \pm 8\text{V}, V_{SS} = 0\text{V}$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	$V_{GS(TH)}$	0.5	—	1.3	V	$V_{SS} = 10\text{V}, I_S = 1.0\text{mA}$
Static Source-Source On-Resistance	$R_{SS(ON)}$	20	29	45	m Ω	$V_{GS} = 4.5\text{V}, I_S = 3.0\text{A}$
		20.5	30	48		$V_{GS} = 4.0\text{V}, I_S = 3.0\text{A}$
		21	31	50		$V_{GS} = 3.7\text{V}, I_S = 3.0\text{A}$
		22	33	57		$V_{GS} = 3.1\text{V}, I_S = 3.0\text{A}$
		23	36	72		$V_{GS} = 2.5\text{V}, I_S = 3.0\text{A}$
Forward Transfer Admittance	$ Y_{fs} $	—	9.4	—	S	$V_{SS} = 10\text{V}, I_S = 3.0\text{A}$
Body Diode Forward Voltage	$V_{F(S-S)}$	—	0.8	1.2	V	$I_F = 3.0\text{A}, V_{GS} = 0\text{V}$
DYNAMIC CHARACTERISTICS (Note 8)						
Total Gate Charge	Q_g	—	12.6	—	nC	$V_{GS} = 4.5\text{V}, V_{SS} = 10\text{V}, I_S = 6\text{A}$
Turn-On Delay Time	$t_{D(ON)}$	—	183	—	ns	$V_{DD} = 10\text{V},$ $R_L = 3.33\Omega, I_S = 3.0\text{A}$
Turn-On Rise Time	t_R	—	278	—	ns	
Turn-Off Delay Time	$t_{D(OFF)}$	—	738	—	ns	
Turn-Off Fall Time	t_F	—	572	—	ns	

- Notes:
- Device mounted on FR-4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.
 - Repetitive rating, pulse width limited by junction temperature.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to production testing.

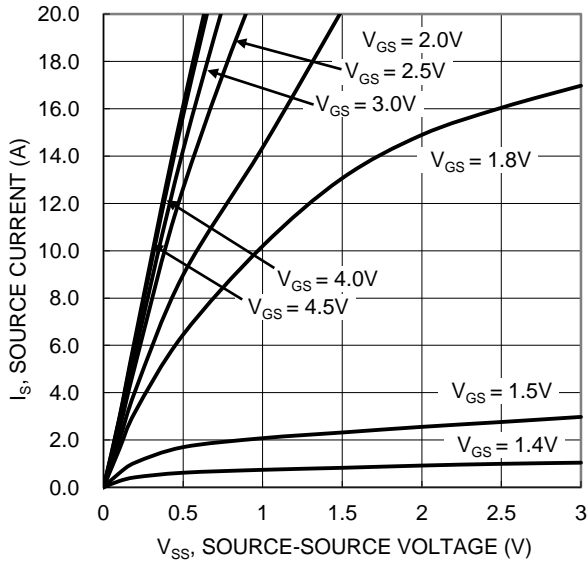


Figure 1. Typical Output Characteristic

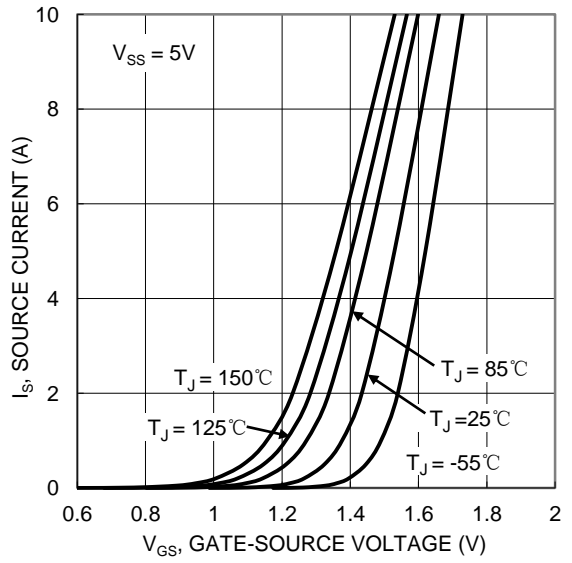


Figure 2. Typical Transfer Characteristic

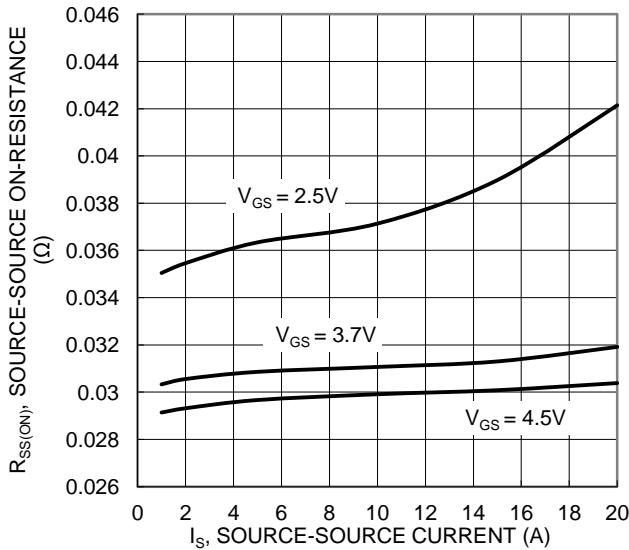


Figure 3. Typical On-Resistance vs. Source Current and Gate Voltage

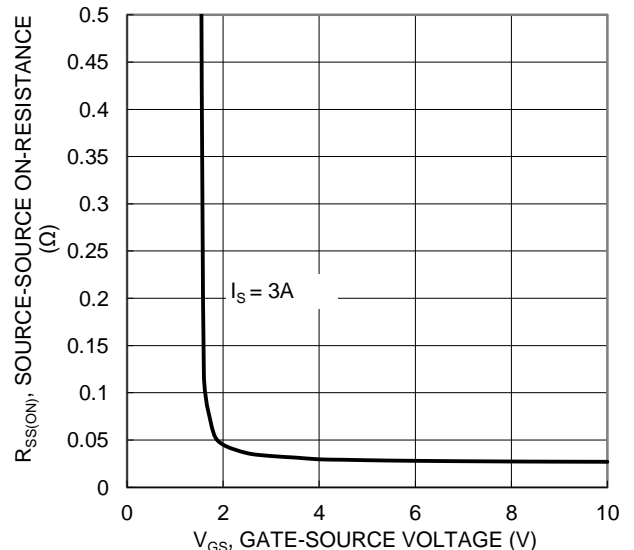


Figure 4. Typical Transfer Characteristic

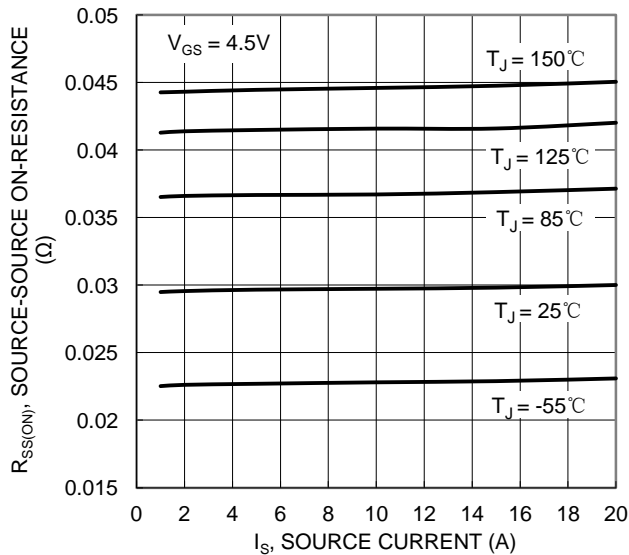


Figure 5. Typical On-Resistance vs. Source Current and Junction Temperature

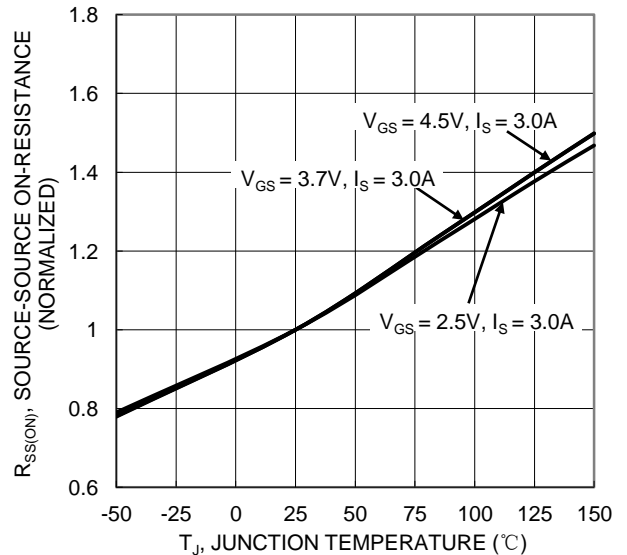


Figure 6. On-Resistance Variation with Junction Temperature

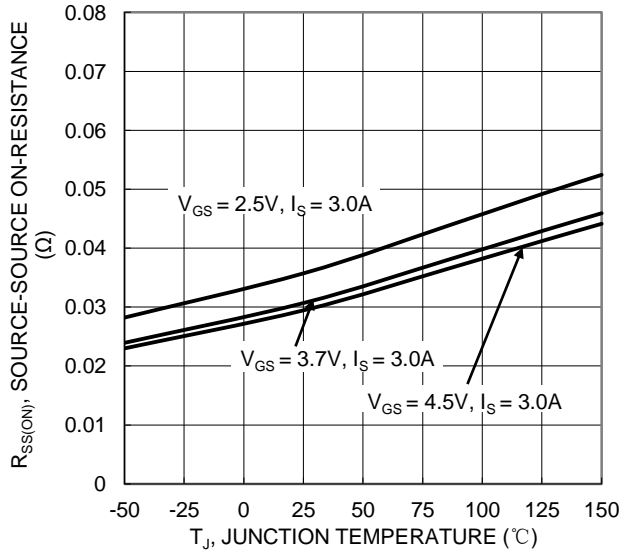


Figure 7. On-Resistance Variation with Junction Temperature

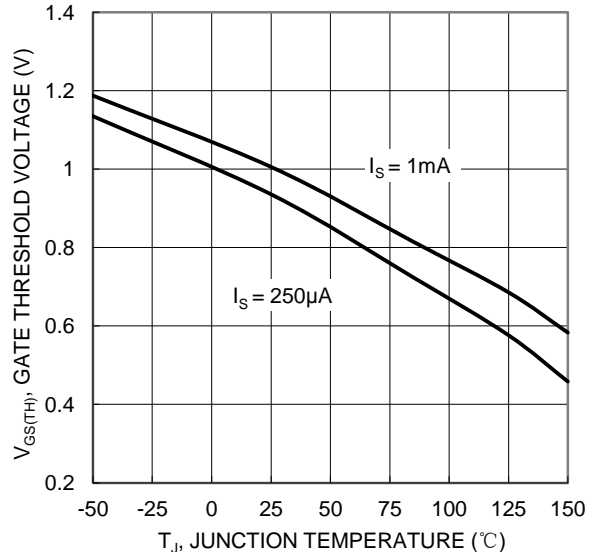


Figure 8. Gate Threshold Variation vs. Junction Temperature

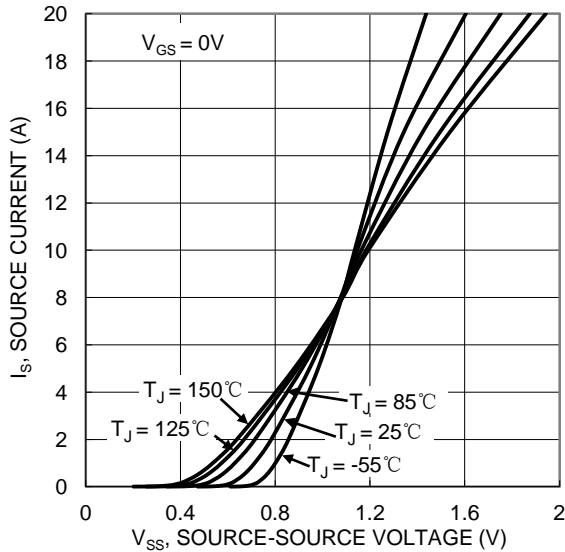


Figure 9. Diode Forward Voltage vs. Current

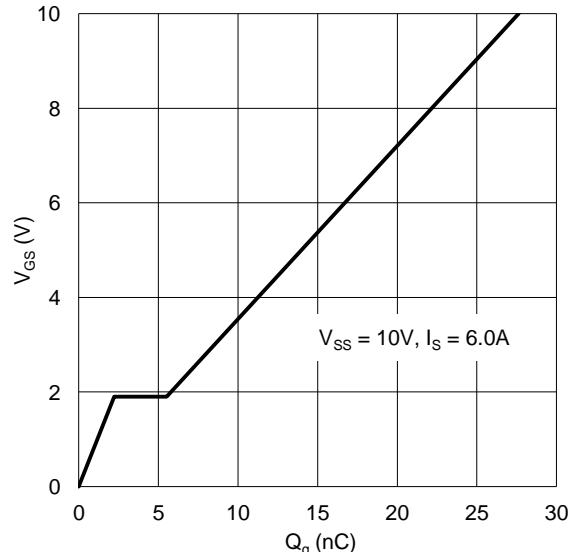


Figure 10. Gate Charge

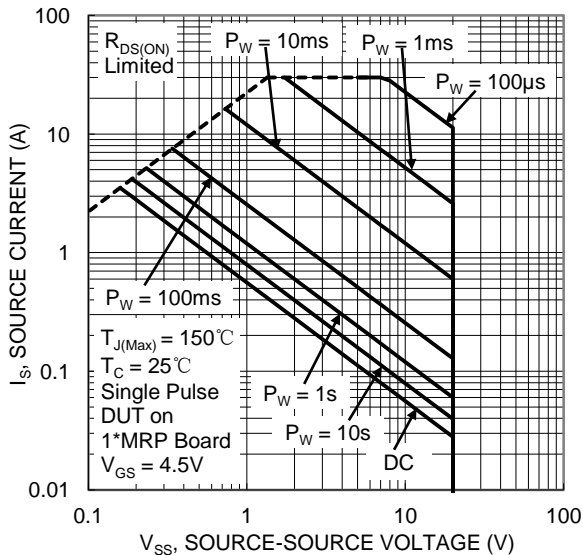


Figure 11. SOA, Safe Operation Area

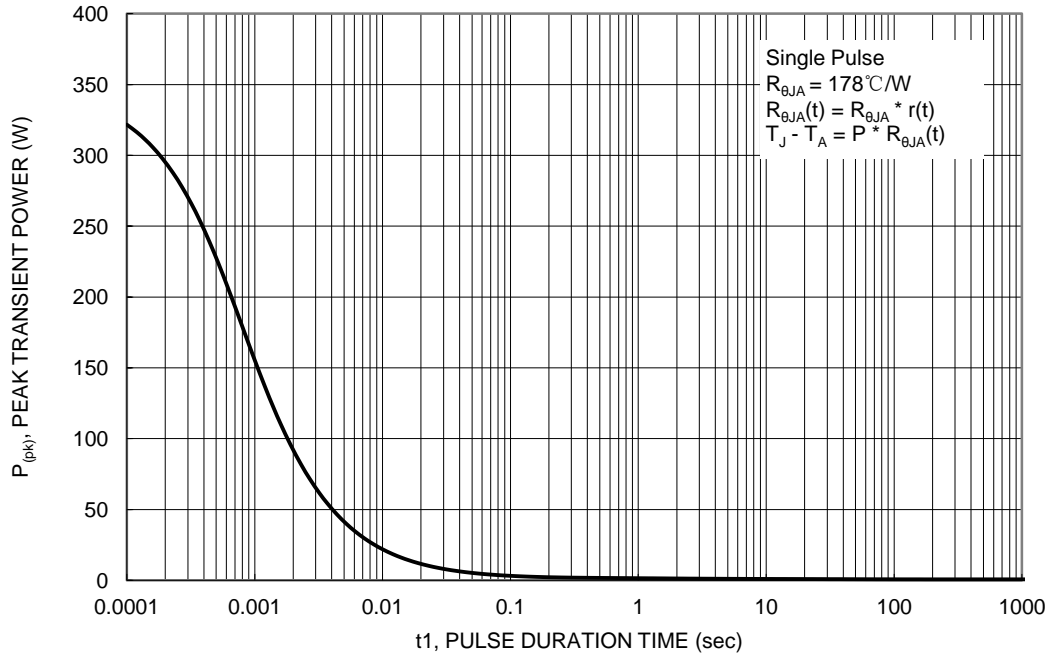


Figure 12. Single Pulse Maximum Power Dissipation

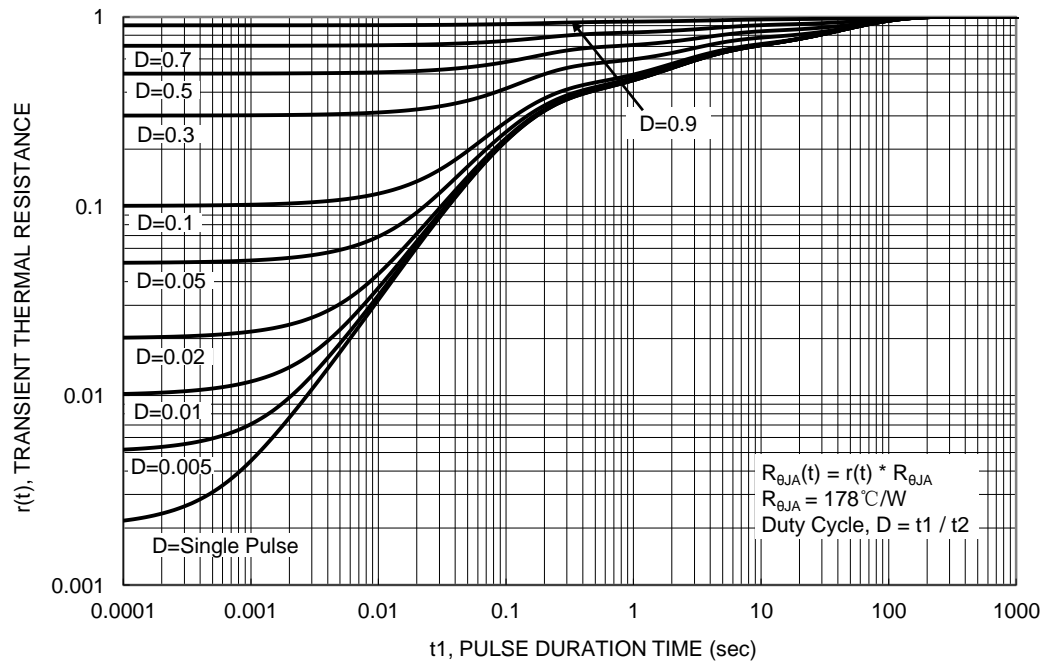
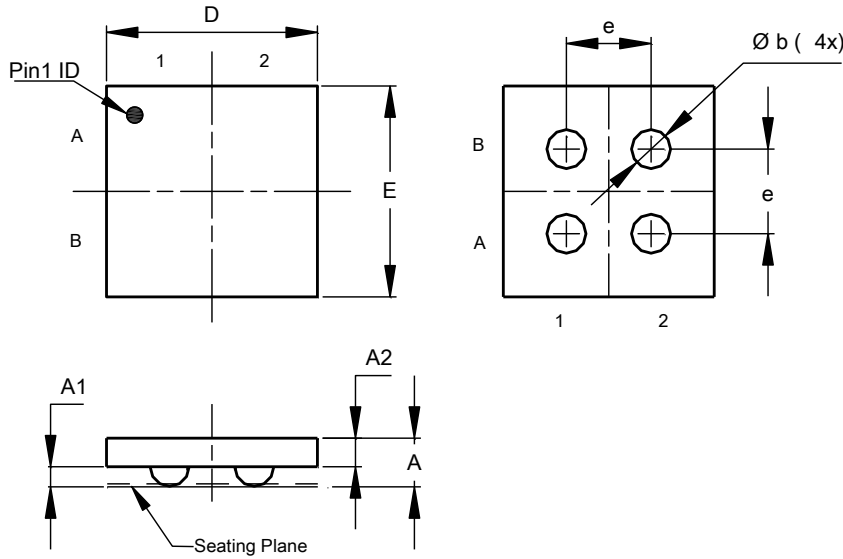


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

X2-WLB1616-4

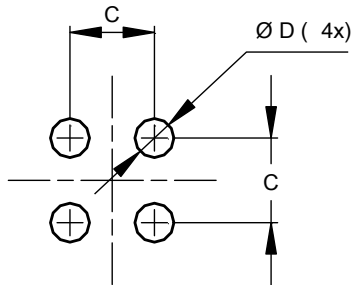


X2-WLB1616-4			
Dim	Min	Max	Typ
A	--	0.40	0.37
A1	--	--	0.15
A2	--	--	0.22
b	0.25	0.35	0.30
D	1.58	1.66	1.62
E	1.58	1.66	1.62
e	-	-	0.65
All Dimensions in mm			

Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

X2-WLB1616-4



Dimensions	Value (in mm)
C	0.65
D	0.30

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